L Number	Hits	Search Text	DB	Time stamp
-	5874	((Transition near2 electron near2 (microscope or microscopy)) or TEM) and	USPAT;	2002/12/16 19:27
		(Beam or probe or arm or (micro near2 hand) or tip or needle)	US-PGPUB;	
			EPO; JPO;	
			DERWENT,	
			IBM_TDB	
	9187	250/310 250/311 250/49 2.2 250/307	USPAT;	2002/12/16 13:13
	2107	250/5/0 250/5/1 250/ / / 250/ / / /	US-PGPUB;	2002/12/10 15.15
			EPO; JPO;	
			DERWENT;	
	•10		IBM_TDB	
-	219	(((Transition near2 electron near2 (microscope or microscopy)) or TEM) and	USPAT;	2002/12/16 13:14
		(Beam or probe or arm or (micro near2 hand) or tip or needle)) and	US-PGPUB;	
		(250/310 250/311 250/492.2 250/307)	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	3868	((Transition near2 electron near2 (microscope or microscopy)) or TEM) and	USPAT;	2002/12/16 19:27
		(Beam or probe or arm or (micro near2 hand) or tip or needle) and (sample	US-PGPUB;	
İ		or workpiece or specimen)	EPO; JPO;	
		or monipose of openium,	DERWENT;	
			IBM_TDB	
	205	(((Transition near2 electron near2 (microscope or microscopy)) or TEM) and		2002/12/16 16 26
-	205		USPAT;	2002/12/16 16:26
		(Beam or probe or arm or (micro near2 hand) or tip or needle) and (sample	US-PGPUB;	
1		or workpiece or specimen)) and (250/310 250/311 250/492.2 250/307)	EPO; JPO;	
		·	DERWENT;	
			IBM_TDB	
-	2	4939364.pn.	USPAT;	2002/12/16 16:29
		•	US-PGPUB;	
1			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
	2	5093572.pn.		2002/12/16 16:21
-	2	3093372.pii.	USPAT;	2002/12/16 16:31
!			US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	2	5171717.pn.	USPAT;	2002/12/16 16:32
			US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
-			IBM TDB	
	2	5270552.pn.	USPAT;	2002/12/16 17:37
	-		US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
1	_	5053300	IBM_TDB	2002//2//
-	2	5852298.pn.	USPAT;	2002/12/16 17:53
			US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	0	"method and apparatus for preparing samples".ti.	USPAT;	2002/12/16 18:00
	•		US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
-		4 1 (200(21 D))	IBM_TDB	2002/12/15 10 11
	41	method near 6300631.PN. apparatus near3 preparing adj samples.ti.	USPAT;	2002/12/16 18:00
			US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
l l			,	I .

US-PGPUB EPO, IPO, DERWENT; IBM_TDB USPAT; US-PGPUB; EPO, IPO; DERWENT; IBM_TDB US-PGPUB; EPO; IPO; DERWENT; IBM_TDB US-PGPUB;	
Propagation	12/16 18:00
DERWENT; IBM TDB USPAT; USPA	
IBM_TDB SPAT; US-PGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; US-PGPUB; EPO, IPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; IPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; IPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; IPO; DERWENT; IPO; DERWENT; IPO; DERWENT; IPO; DERWENT; IPO; DERWENT; IPO; DERWE	
- 6 method adj apparatus adj preparing adj sample.ti. USPAT, 2002/ USPAT, USPA	
US-PGPUB EPO, JPO, DERWENT, IBM_TDB USPAT, US-PGPUB EPO, JPO, D	
-	12/16 18:02
-	
BIM_TDB USPAT; 2002/ US-PGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; USPGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; USPGPUB; EPO; IPO, DERWENT; IBM_TDB USPAT; USPGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; USPAT; USPGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; USPAT; USPGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; USPGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; USPGPUB; EPO, IPO, DERWENT; IBM_TDB USPAT; USPAT;	
-	
1.	
Peo_i Po_i Derwent Peo_i Po_i Po_i Po_i Po_i Po_i Po_i Po_i P	12/16 18:04
- 726455 Hitachi.as. - 726455 Hitachi.as. - 726455 Hitachi.as. - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) - 0 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) - 0 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 - 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) - 2 5270552.pn. - 3 686273 Hitachi.as. and @ad>1995 - 4 686273 Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti.	
Table Tabl	
-	
-	
- 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) - 0 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 - 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) us-PGPUB, EPO, IPO, DER.WENT, IBM_TDB - 2 5270552.pn. - 686273 Hitachi.as. and @ad>1995 - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti.	12/16 18:06
- 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) - 0 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 - 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) us-PGPUB, EPO, IPO, DER.WENT, IBM_TDB - 2 5270552.pn. - 686273 Hitachi.as. and @ad>1995 - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti.	
- 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) - 0 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 - 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) and @ad>1996 - 2 5270552.pn. - 3 686273 Hitachi.as. and @ad>1995 - 4 686273 Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti.	
270	
270	
(microscope or microscopy)) or TEM) (microscope or microscopy)) or TEM) (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microscope or microscopy)) or TEM) ((Transmission adj electron adj (microsc	12/16 18:10
Comparison of the property o	•
- 0 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad=1997 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 - 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 - 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) - 2 5270552.pn. - 2 5270552.pn. - 686273 Hitachi.as. and @ad>1995 - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti.	
- 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (Microscope or microscopy)) or TEM) and @ad=1997 (Mispat; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB (USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EP	
-	
(microscope or microscopy)) or TEM) and @ad=1997 US-PGPUB; EPO; JPO; DER WENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; JPO; DER WENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DER WENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; JPO; JPO; JPO; JPO; JPO; JPO; J	12/16 18:11
- 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; E	
- 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; E	
- 270 (Hitachi.as. and @ad>1995) and ((Transition near2 electron near2 (microscope or microscopy)) or TEM) and @ad>1996 USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; ISPAT; US-PGPUB; EPO; JPO; DERWENT;	
- 270	
- 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) - 2 (Transmission adj electron adj (microscope or microscopy)) or TEM) - 2 5270552.pn. - 686273 Hitachi.as. and @ad>1995 - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; ISONE EPO; JPO; DERWENT;	12/16 18:11
18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; EPO; JPO;	
- 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) - 2 5270552.pn. - 2 5270552.pn. - 686273 Hitachi.as. and @ad>1995 - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. DERWENT; IBM_TDB 2002/ USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; USPAT; USPGPUB; EPO; JPO; DERWENT; USPAT; USP	
- 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) - 2 5270552.pn. - 2 5270552.pn. - 686273 Hitachi.as. and @ad>1995 - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; ISON DEVICE).ti.	
- 18631 ((Transmission adj electron adj (microscope or microscopy)) or TEM) - 2 5270552.pn. - 25270552.pn. - 686273 Hitachi.as. and @ad>1995 - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. - 18631 (USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT;	
US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; DEVICE).ti.	12/16 19:34
EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT;	
DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DEVICE).ti.	
- 2 5270552.pn. IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DEVICE).ti. USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPU	
- 2 5270552.pn. USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DEVICE).ti. 2002/	
- 686273 Hitachi.as. and @ad>1995 Hitachi.as. and @ad>1995 Hitachi.as. and @ad>1995 US-PGPUB; EPO; JPO; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DEVICE).ti. US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT;	12/17 15:31
- 686273 Hitachi.as. and @ad>1995 Hitachi.as. and @ad>1995 Hitachi.as. and @ad>1995 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DERWENT;	
- 686273 Hitachi.as. and @ad>1995 Hitachi.as. and @ad>1995 USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; US-PGPUB; EPO; JPO; DEVICE).ti. (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. DERWENT; US-PGPUB; EPO; JPO; DERWENT;	
- 686273 Hitachi.as. and @ad>1995 Hitachi.as. and @ad>1995 USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DEVICE).ti. (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. 2002/ USPAT; US-PGPUB; EPO; JPO; DERWENT;	
- 686273 Hitachi.as. and @ad>1995 USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DEVICE).ti. (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. 2002/ USPAT; US-PGPUB; EPO; JPO; DERWENT;	
US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DEVICE).ti.	12/17 15:43
- 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. EPO; JPO; DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	
- 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. DERWENT; IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	
- (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and DEVICE).ti. IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT;	
- 5 (Hitachi.as. and @ad>1995) and (MANIPULATOR and PROBE and USPAT; US-PGPUB; EPO; JPO; DERWENT;	
DEVICE).ti. US-PGPUB; EPO; JPO; DERWENT;	12/17 15:44
EPO; JPO; DERWENT;	
DERWENT;	
	2/19 11:09
or vaccum) US-PGPUB;	
EPO; JPO;	
DERWENT;	
IBM_TDB	
	2/19 11:09
US-PGPUB;	
EPO; JPO;	
DERWENT;	
IBM TDB	

	2180	(250/310 250/311 250/307 250/492.1 250/440.11) and ((Beam or probe or	USPAT;	2002/12/10 11 00
-	2180	arm or (micro near2 hand) or tip or needle) and (vacuum or vaccum))	US-PGPUB;	2002/12/19 11:09
	1	and of (micro nearz hand) of the of needle) and (vacuum of vaccum))	EPO; JPO;	
			DERWENT;	
	49461	(Beam or probe or arm or (micro near2 hand) or tip or needle) with (vacuum	IBM_TDB	2002/12/10 11 12
-	49401		USPAT;	2002/12/19 11:12
		or vaccum)	US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
	1107	((Danis an araba an araba an araba an araba an (ariana araba an ar	IBM_TDB	2002/12/10 11 11
•	1107	((Beam or probe or arm or (micro near2 hand) or tip or needle) with	USPAT;	2002/12/19 11:11
		(vacuum or vaccum)) and (250/310 250/311 250/307 250/492.1 250/440.11)	US-PGPUB;	
			EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	7741	((Beam or probe or arm or (micro near2 hand) or tip or needle) with	USPAT;	2002/12/19 11:17
		(vacuum or vaccum)) and (((Scanning adj electron adj microscope) or	US-PGPUB;	
		(scanning near3 microscope) or SEM) or (ion adj beam))	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	742	(((Beam or probe or arm or (micro near2 hand) or tip or needle) with	USPAT;	2002/12/19 11:16
		(vacuum or vaccum)) and (((Scanning adj electron adj microscope) or	US-PGPUB;	
		(scanning near3 microscope) or SEM) or (ion adj beam))) and (250/310	EPO; JPO;	
		250/311 250/307 250/4 92.1 250/440.11)	DERWENT;	
			IBM_TDB	
-	4540	((Beam or probe or arm or (micro near2 hand) or tip or needle) near5	USPAT;	2002/12/19 11:19
		(vacuum or vaccum)) and (((Scanning adj electron adj microscope) or	US-PGPUB;	
		(scanning near3 microscope) or SEM) or (ion adj beam))	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
-	451	(((Beam or probe or arm or (micro near2 hand) or tip or needle) near5	USPAT;	2002/12/19 11:19
		(vacuum or vaccum)) and (((Scanning adj electron adj microscope) or	US-PGPUB;	
		(scanning near3 microscope) or SEM) or (ion adj beam))) and (250/310	EPO; JPO;	
		250/311 250/307 250/4 92.1 250/440.11)	DERWENT;	
		·	IBM_TDB	
•	2737	((Beam or probe or arm or (micro near2 hand) or tip or needle) near3	USPAT;	2002/12/19 11:21
		(vacuum or vaccum)) and (((Scanning adj electron adj microscope) or	US-PGPUB;	
		(scanning near3 microscope) or SEM) or (ion adj beam))	EPO; JPO;	
			DERWENT;	
			IBM_TDB	
_	304	(((Beam or probe or arm or (micro near2 hand) or tip or needle) near3	USPAT;	2002/12/19 11:22
		(vacuum or vaccum)) and (((Scanning adj electron adj microscope) or	US-PGPUB;	
		(scanning near3 microscope) or SEM) or (ion adj beam))) and (250/310	EPO; JPO;	
		250/311 250/307 250/492.1 250/440.11)	DERWENT;	
			IBM TDB	
	<u> </u>	1	10111100	l